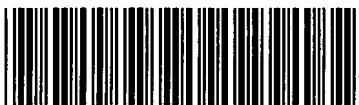


<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	09772986	HAYASHI ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Tran, Thien F	2811

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
257	59,64-66,70,72,75,347	11/14/2007	TT

<b>SEARCH NOTES</b>			
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>	
search history printout	11/14/2007	TT	
search history printout	11/15/2007	TT	

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>